



# Power MOSFETS

## DATASHEET

**LM30074NAK8A**

N-Channel  
Enhancement Mode MOSFET

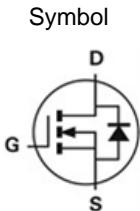
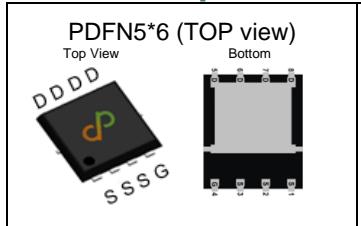
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Quality Management Systems  
ISO 9001:2015 Certificate

## N-Channel Enhancement Mode MOSFET

### Pin Description



### Ordering Information

| Symbol           | N-Channel | Unit      |
|------------------|-----------|-----------|
| $V_{DSS}$        | 30        | V         |
| $R_{DS(ON)-Max}$ | 7.4       | $m\Omega$ |
| $I_D$            | 50        | A         |

### Feature

- Lower  $R_{DS(ON)}$  to Minimize Conduction Losses
- Reliable and Rugged
- ROHS Compliant & Halogen-Free
- 100% UIS and  $R_g$  Tested

### Applications

- Portable Equipment
- Battery Powered System

### Ordering Information

| Orderable Part Number | Package Type | Form        | Shipping           | Marking          |
|-----------------------|--------------|-------------|--------------------|------------------|
| LM30074NAK8A          | PDFN5*6      | Tape & Reel | 5000 / Tape & Reel | 30074<br>□□□□□□□ |

### Absolute Maximum Ratings (T<sub>J</sub>=25°C Unless Otherwise Noted)

| Symbol       | Parameter                       | N-Channel         | Unit |
|--------------|---------------------------------|-------------------|------|
| $V_{DSS}$    | Drain-Source Voltage            | 30                | V    |
| $V_{GSS}$    | Gate-Source Voltage             | $\pm 20$          |      |
| $T_J$        | Maximum Junction Temperature    | 150               | °C   |
| $T_{STG}$    | Storage Temperature Range       | -55 to 150        | °C   |
| $I_{DM}^{①}$ | Pulse Drain Current Tested      | $T_c=25^\circ C$  | A    |
| $I_D$        | Continuous Drain Current        | $T_c=25^\circ C$  | A    |
|              |                                 | $T_c=100^\circ C$ |      |
| $P_D$        | Maximum Power Dissipation       | $T_c=25^\circ C$  | W    |
|              |                                 | $T_c=100^\circ C$ |      |
| $I_{AS}^{②}$ | Avalanche Current, Single pulse | L=0.1mH           | A    |
| $E_{AS}^{②}$ | Avalanche Energy, Single pulse  | L=0.1mH           | mJ   |

### Thermal Characteristics

| Symbol        | Parameter                              | Rating       | Unit     |
|---------------|--|--------------|----------|
| $R_{θJC}$     | Thermal Resistance-Junction to Case    | Steady State | 3.9 °C/W |
| $R_{θJA}^{③}$ | Thermal Resistance-Junction to Ambient | Steady State | 98 °C/W  |

Note ① : Max. current is limited by bonding wire

Note ② : UIS tested and pulse width are limited by maximum junction temperature 150°C

Note ③ : Surface Mounted on 1in<sup>2</sup> FR-4 board with 1oz.

N-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  Unless Otherwise Noted)

| Symbol  | Parameter                        | Test Conditions   | Min. | Typ. | Max.      | Unit             |
|---|----------------------------------|---|------|------|-----------|------------------|
| <b>Static Electrical Characteristics</b>      |                                  |   |      |      |           |                  |
| $\mathbf{BV_{DSS}}$                           | Drain-Source Breakdown Voltage   | $V_{GS}=0\text{V}, I_{DS}=250\mu\text{A}$                                   | 30   | -    | -         | V                |
| $I_{DSS}$                                     | Zero Gate Voltage Drain Current  | $V_{DS}=24\text{V}, V_{GS}=0\text{V}$                                       | -    | -    | 1         | $\mu\text{A}$    |
| $V_{GS(\text{th})}$                           | Gate Threshold Voltage           | $V_{DS}=V_{GS}, I_{DS}=250\mu\text{A}$                                      | 1.1  | 1.6  | 2.1       | V                |
| $I_{GSS}$                                     | Gate Leakage Current             | $V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$                                   | -    | -    | $\pm 100$ | $\text{nA}$      |
| $R_{DS(\text{ON})}^{\text{(4)}}$              | Drain-Source On-state Resistance | $V_{GS}=10\text{V}, I_{DS}=8\text{A}$                                       | -    | 6.2  | 7.4       | $\text{m}\Omega$ |
|   |                                  | $V_{GS}=4.5\text{V}, I_{DS}=6\text{A}$                                      | -    | 8.2  | 10.7      |                  |
| $g_{fs}$                                      | Forward Transconductance         | $V_{DS}=5\text{V}, I_{DS}=8\text{A}$  | -    | 12   | -         | S                |
| <b>Dynamic Characteristics <sup>(5)</sup></b> |                                  |   |      |      |           |                  |
| $R_G$   | Gate Resistance                  | $V_{GS}=0\text{V}, V_{DS}=0\text{V},$<br>Freq.=1MHz                         | -    | 3.5  | -         | $\Omega$         |
| $C_{iss}$                                     | Input Capacitance                | $V_{GS}=0\text{V},$<br>$V_{DS}=15\text{V},$<br>Freq.=1MHz                   | -    | 1094 | -         | $\text{pF}$      |
| $C_{oss}$                                     | Output Capacitance               |   | -    | 147  | -         |                  |
| $C_{rss}$                                     | Reverse Transfer Capacitance     |   | -    | 127  | -         |                  |
| $t_{d(\text{ON})}$                            | Turn-on Delay Time               | $V_{GS}=10\text{V}, V_{DS}=15\text{V},$<br>$I_D=1\text{A}, R_{GEN}=6\Omega$ | -    | 6    | -         | $\text{nS}$      |
| $t_r$   | Turn-on Rise Time                |   | -    | 22.5 | -         |                  |
| $t_{d(\text{OFF})}$                           | Turn-off Delay Time              |   | -    | 48.6 | -         |                  |
| $t_f$   | Turn-off Fall Time               |   | -    | 19.8 | -         |                  |
| $Q_g$   | Total Gate Charge                | $V_{GS}=4.5\text{V}, V_{DS}=15\text{V}$<br>$I_D=8\text{A}$                  | -    | 16   | -         | $\text{nC}$      |
| $Q_g$   | Total Gate Charge                | $V_{GS}=10\text{V}, V_{DS}=15\text{V},$<br>$I_D=8\text{A}$                  | -    | 31   | -         |                  |
| $Q_{gs}$                                      | Gate-Source Charge               |   | -    | 1.4  | -         |                  |
| $Q_{gd}$                                      | Gate-Drain Charge                |   | -    | 9.3  | -         |                  |
| <b>Source-Drain Characteristics</b>           |                                  |   |      |      |           |                  |
| $V_{SD}^{\text{(4)}}$                         | Diode Forward Voltage            | $I_{SD}=1\text{A}, V_{GS}=0\text{V}$  | -    | 0.7  | 1.1       | V                |
| $t_{rr}$                                      | Reverse Recovery Time            | $I_F=1\text{A}, V_R=0$<br>$dI_F/dt=100\text{A}/\mu\text{s}$                 | -    | 14   | -         | $\text{nS}$      |
| $Q_{rr}$                                      | Reverse Recovery Charge          |   | -    | 5.6  | -         | $\text{nC}$      |

Note <sup>(4)</sup> : Pulse test (pulse width $\leq 300\text{us}$ , duty cycle $\leq 2\%$ ).Note <sup>(5)</sup> : Guaranteed by design, not subject to production testing.

## N-Channel Typical Characteristics

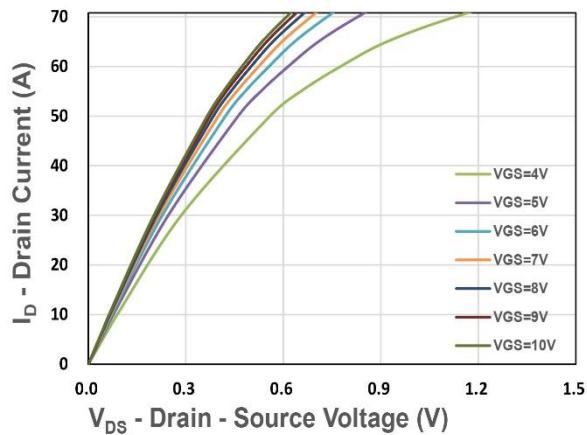


Figure 1. Output Characteristics

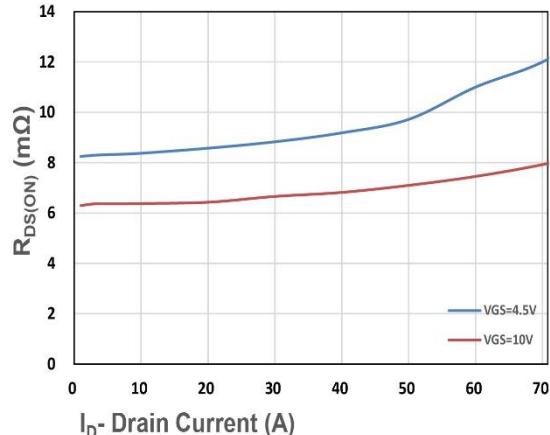


Figure 2. On-Resistance vs. ID

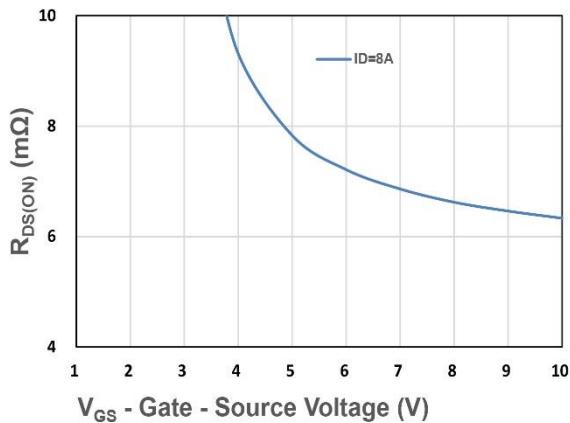


Figure 3. On-Resistance vs. VGS

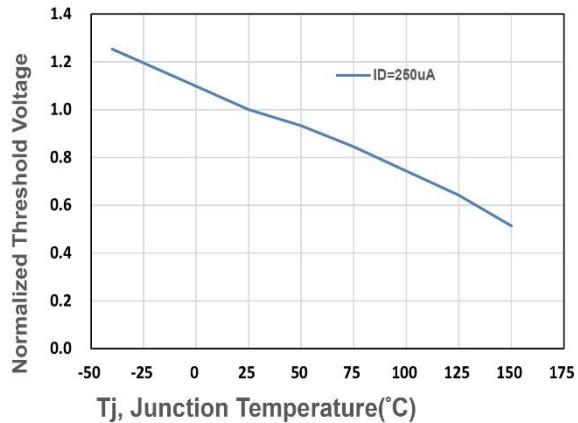


Figure 4. Gate Threshold Voltage

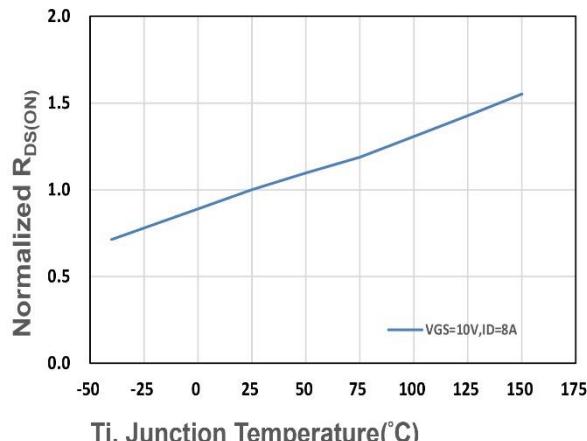


Figure 5. Drain-Source On Resistance

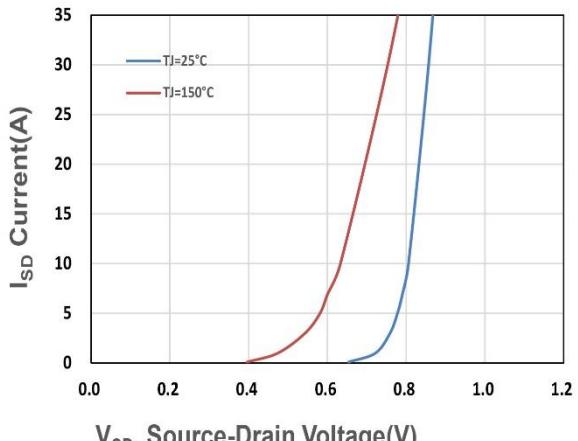


Figure 6. Source-Drain Diode Forward

# LM30074NAK8A

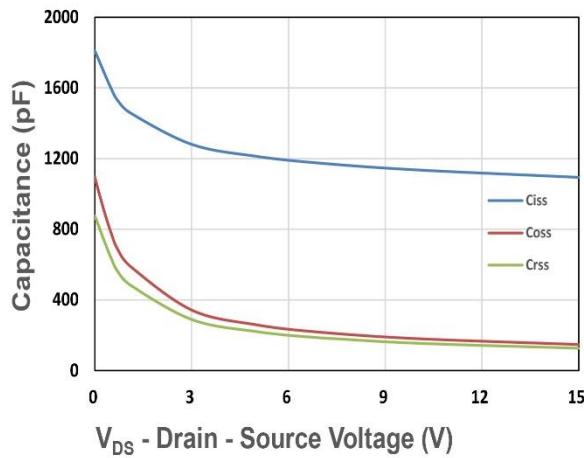


Figure 7. Capacitance

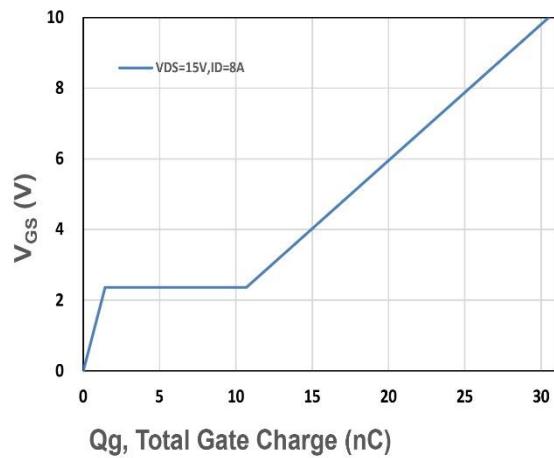


Figure 8. Gate Charge Characteristics

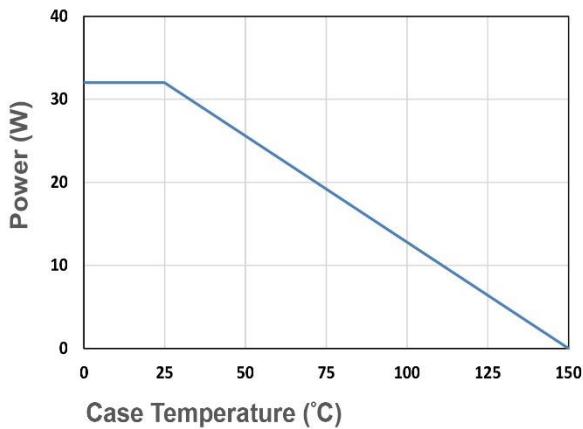


Figure 9. Power Dissipation

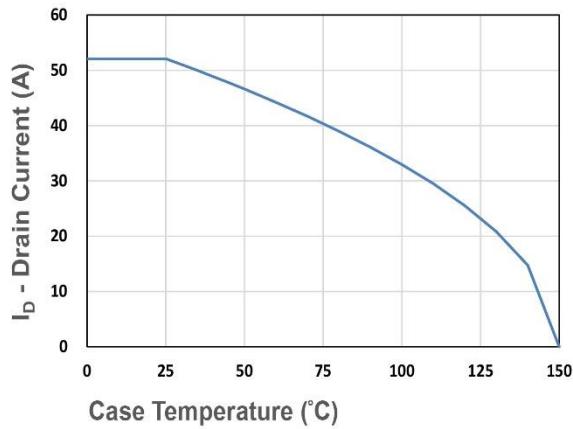


Figure 10. Drain Current

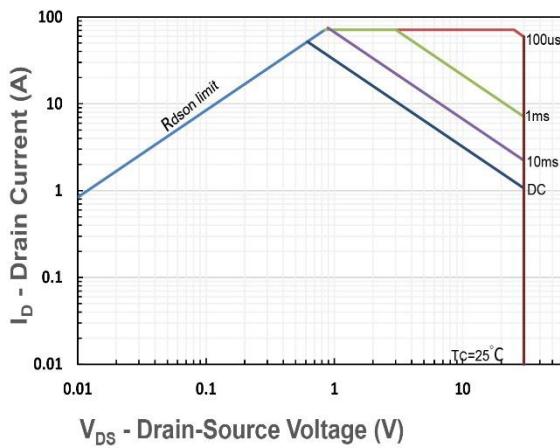


Figure 11. Safe Operating Area

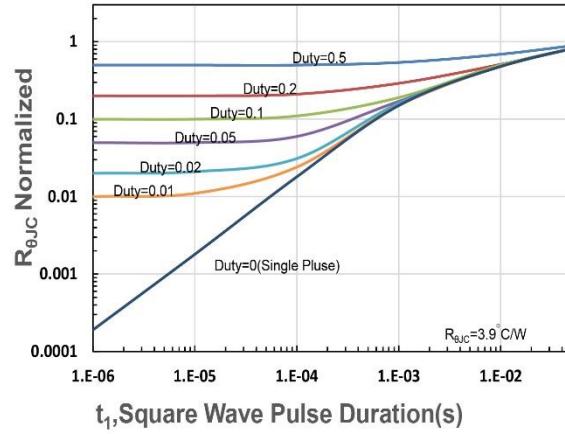


Figure 12. R<sub>θJC</sub> Transient Thermal Impedance